

Notice of References Cited	Application/Control No. 09/715,087	Applicant(s)/Patent Under Reexamination ISHIDA, AKIRA	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,594,250	07-2003	Silventoinen et al.	370/347
	B	US-6,453,177	09-2002	Wong et al.	455/562.1
	C	US-6,498,804	12-2002	Ide et al.	375/144
	D	US-6,504,830	01-2003	Ostberg et al.	370/342
	E	US-6,539,227	03-2003	Jetzek et al.	455/442
	F	US-6,522,898	02-2003	Kohno et al.	455/562.1
	G	US-6,411,612	06-2002	Halford et al.	370/347
	H	US-6,415,163	07-2002	Keskitalo et al.	455/562.1
	I	US-6,438,389	08-2002	Sandhu et al.	455/562.1
	J	US-6,370,128	04-2002	Raitola, Mika	370/329
	K	US-6,324,397	11-2001	Adachi et al.	455/422.1
	L	US-6,141,335	10-2000	Kuwahara et al.	370/342
	M	US-5,708,441	01-1998	Kanai, Toshihito	342/359

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-11-74831	03-1999	JP	Akihiro et al	H04B 7/26
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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